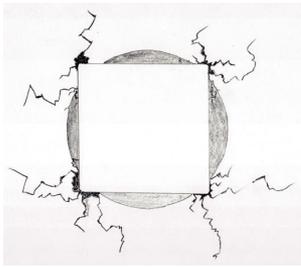


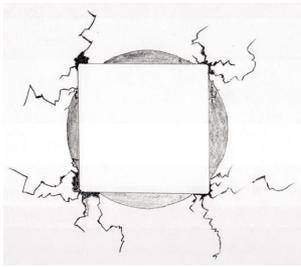
*Could the
Software Engineering Institute
be Wrong About
Statistical Process Control?*

Bob Raczynski



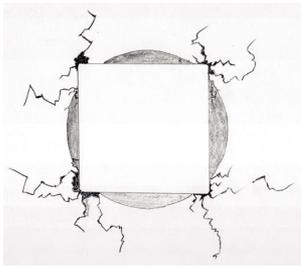
SPC – Some History

- ◆ Invented by Dr. Walter A. Shewhart in the 1920s
- ◆ Popularized by Dr. W. E. Deming in the 1950s
- ◆ Transformed the manufacturing world
- ◆ The SEI Capability Maturity Model for Software (SW-CMM) included SPC as an integral component in the early 1990s - in the name of “predictability of process performance.”



What is SPC?

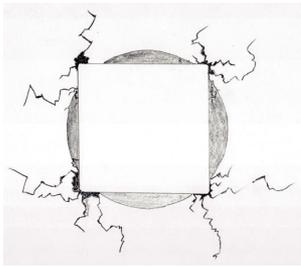
- ◆ “SPC is a way of thinking which happens to have some tools attached.” – Dr. Donald J. Wheeler
- ◆ 2 main concepts:
 - ◆ Eliminate assignable (special) causes of variation where appropriate (uncontrolled variation)
 - ◆ Understand normal (common) causes of variation (chance variation)



CMMI for Development, Version 1.2

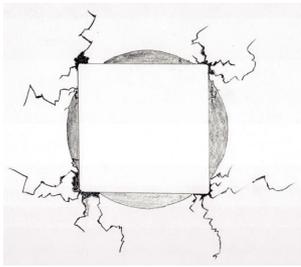
- ◆ Maturity Level 4: Quantitatively Managed
 - ◆ “Special causes of process variation are identified and, where appropriate, the sources of special causes are corrected to prevent future occurrences.”

- ◆ Maturity Level 5: Optimizing
 - ◆ “Processes are continually improved based on a quantitative understanding of the common causes of variation inherent in processes.”



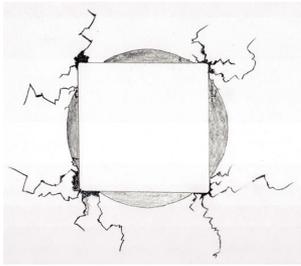
CMMI for Development, Version 1.2

- ◆ The term "variation" is used 83 times in the CMMI.
- ◆ The term "special cause" is used 39 times in the CMMI.
- ◆ The term "common cause" is used 19 times in the CMMI.



CMMI for Development, Version 1.2 – QPM PA

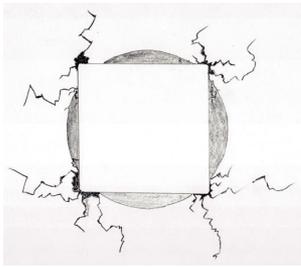
- ◆ SG 2 Statistically Manage Subprocess Performance
 - ◆ SP 2.1 Select Measures and Analytic Techniques
 - ◆ SP 2.2 Apply Statistical Methods to Understand Variation
 - ◆ SP 2.3 Monitor Performance of the Selected Subprocesses
 - ◆ SP 2.4 Record Statistical Management Data



CMMI for Development, -Version 1.2

“Statistically managed process –

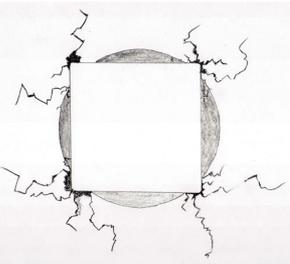
A process that is managed by a statistically based technique in which processes are analyzed, special causes of process variation are identified, and performance is contained within well-defined limits.”



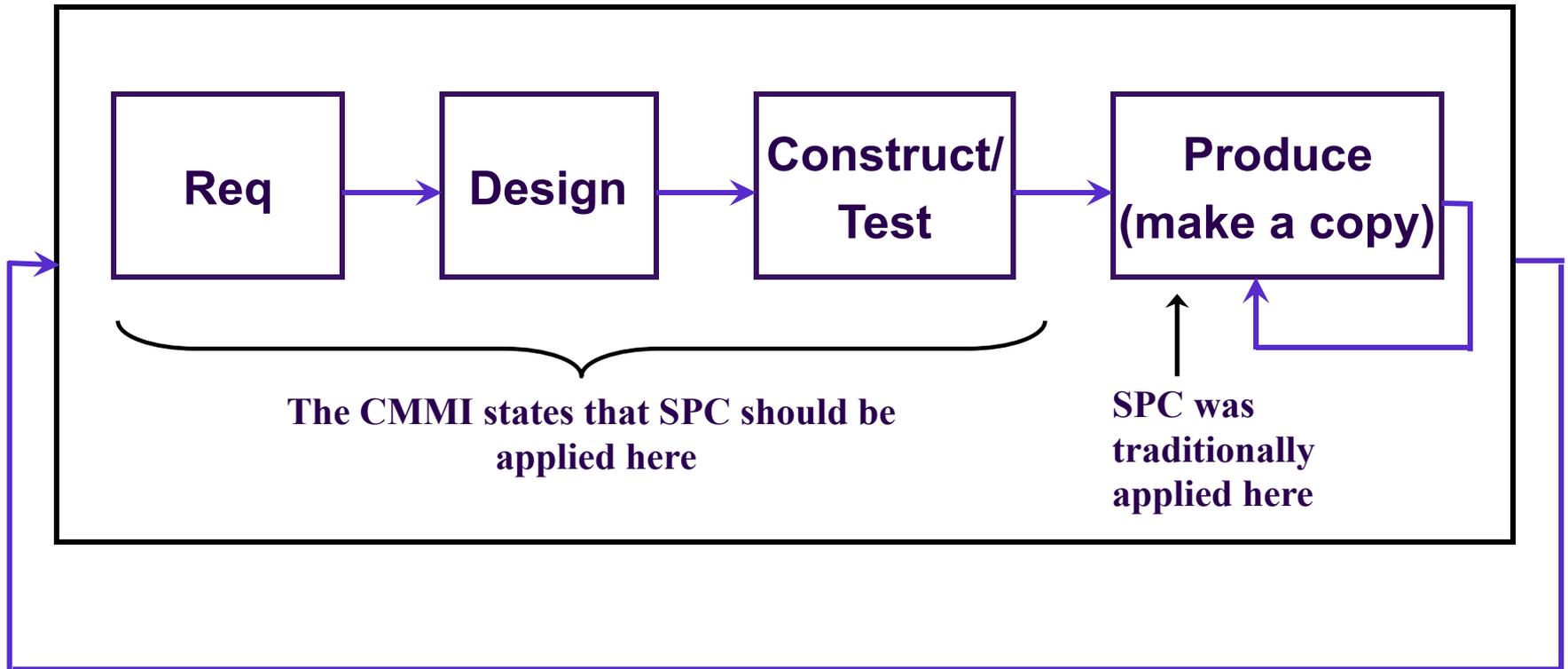
My Point:



- ◆ SPC has a significant amount of emphasis placed upon it within the CMMI
- ◆ An organization can't exceed CMMI Level 3 without doing SPC



Digital vs. Physical Product Manufacturing



IEEE Std 982.1-1988

IEEE Standard Dictionary of Measures to Produce Reliable Software

IEEE Standards Board
Approved June 9, 1988

American National Standards Institute
Approved August 10, 1989

Sponsor
Software Engineering Standards Subcommittee of the Technical Committee on
Software Engineering
of the
IEEE Computer Society

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PDF: ISBN 0-7301-0307-7, 5012542

**Contains no
recommendation for
SPC**

Practical Software and Systems Measurement

A Foundation for Objective Project Management

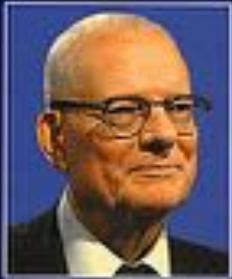


Version 4.0b
October 2000

Department of Defense and US Army

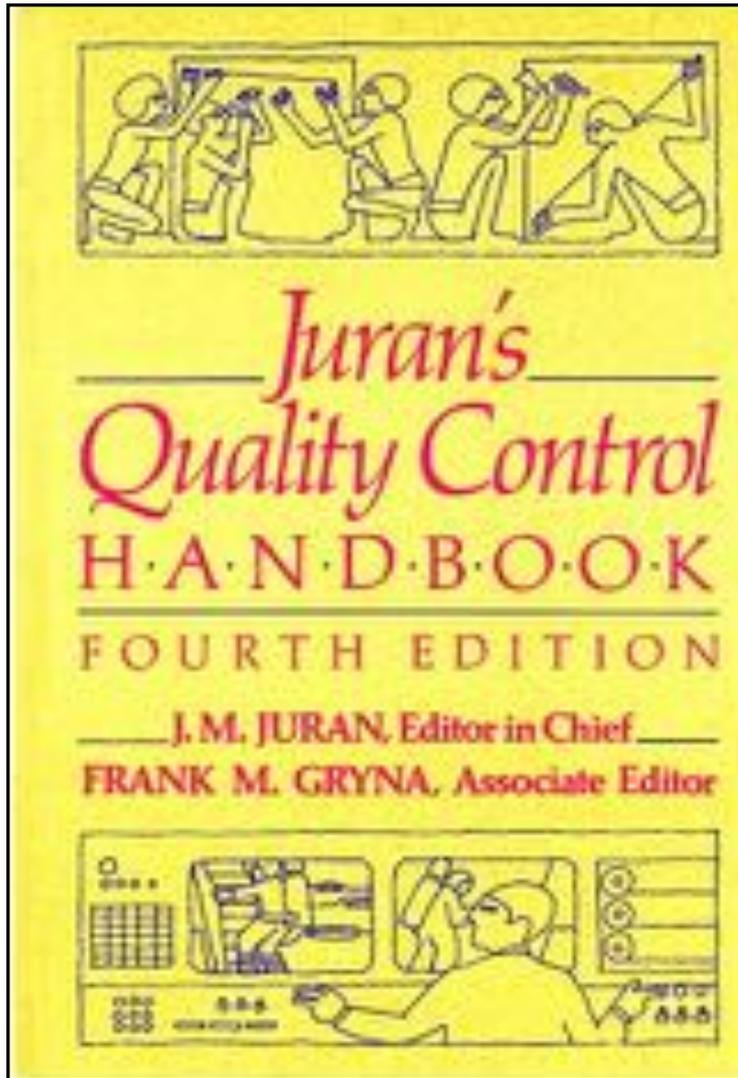
**Contains no
recommendation for
SPC**

W. EDWARDS
DEMING

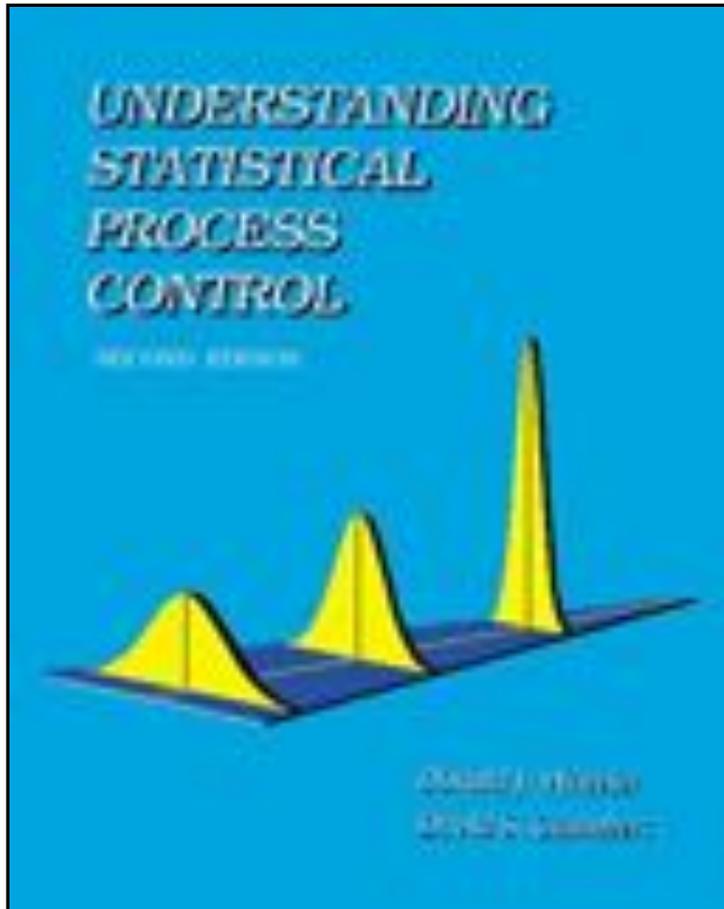


OUT OF
THE CRISIS

“3. Cease dependence on mass inspection. ... We must note that there are exceptions, circumstances in which mistakes and duds are inevitable but intolerable.”



“Unfortunately, as is often the case in such matters, Shewhart's prospectus has become orthodoxy for many of today's quality control practitioners.”



“Attribute Data differ from Measurement Data in two ways. First of all Attribute Data have certain irreducible discreteness which Measurement Data do not possess. Secondly, every count must have a known ‘Area of Opportunity’ to be well-defined”

Statistical Process Control for Software - Mozilla

File Edit View Go Bookmarks Tools Window Help

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PRODUCTS AND SERVICES

- Software Technology Roadmap
- What's New
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Statistical Process Control for Software

Software Technology Roadmap

Status

Complete

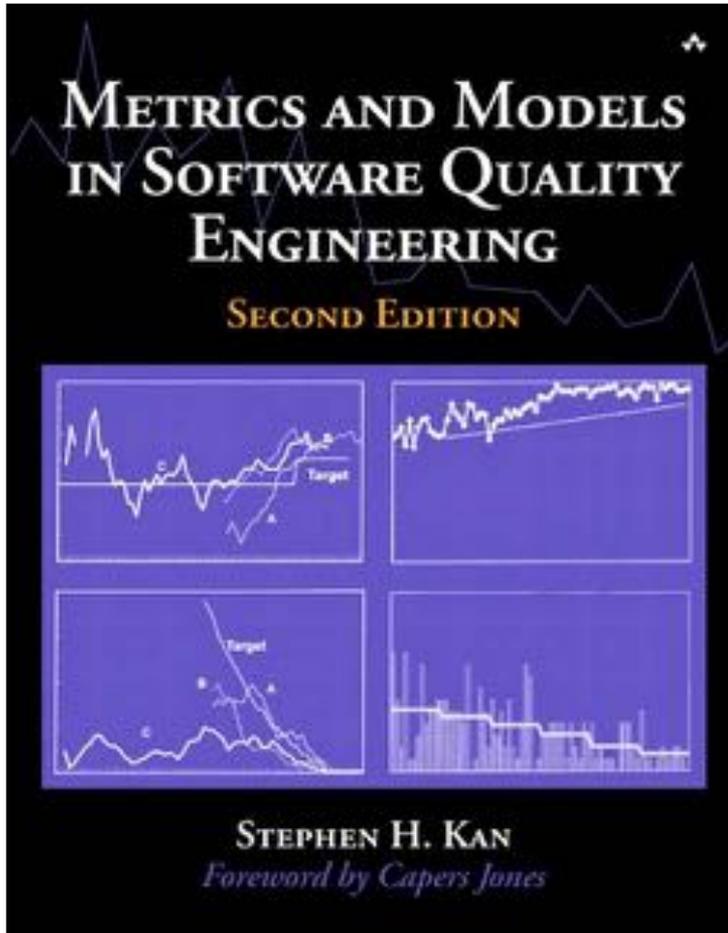
Purpose and Origin

The demand for increased efficiency and effectiveness of our software processes places measurement demands on the software engineering community beyond those traditionally practiced. Statistical and process thinking principles lead to the use of statistical process control methods to determine the consistency and capability of the many processes used to develop software.

Technical Detail

Over the past decade, the concepts, methods, and practices associated with process management and continual improvement have gained wide acceptance in the software community. These concepts, methods, and practices embody a way of thinking, a way of acting, and a way of understanding the data generated by processes that collectively result in improved quality, increased productivity, and competitive products. The acceptance of this "process thinking" approach has motivated many to start measuring software processes that are responsive to questions relating to process performance [Florac 99]. In that vein, traditional software measurement and analysis methods of measuring "planned versus actual" is not sufficient for measuring process performance or for predicting process performance. The time has come to many. If you will, "process thinking"

“Control limits become wider and control charts less sensitive to assignable causes when containing non-homogeneous data”



“However, in software development it is difficult to use control charts in the formal SPC manner. It is a formidable task, if not impossible, to define the process capability of a software development process”

SOMMERVILLE

**Software
Engineering**

7

Quote on next page

First Sommerville quotes Watts Humphrey:

“W. E. Deming, in his work with the Japanese industry after World War II, applied the concepts of statistical process control to industry. While there are important differences, these concepts are just as applicable to software as they are to automobiles, cameras, wristwatches and steel.”

Sommerville then goes on to state:

“While there are clearly similarities, I do not agree with Humphrey that results from manufacturing engineering can be transferred directly to software engineering. Where manufacturing is involved, the process/product relationship is very obvious. Improving a process so that defects are avoided will lead to better products. This link is less obvious when the product is intangible and dependent, to some extent, on intellectual processes that cannot be automated. Software quality is not dependent on a manufacturing process but on a design process where individual human capabilities are significant.”

INTERNATIONAL
STANDARD

ISO
9001

Third edition
2000-12-15

Quality management systems —
Requirements

Systemes de management de la qualite — Exigences



Reference number
ISO 9001:2000

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ISO 9001:2000

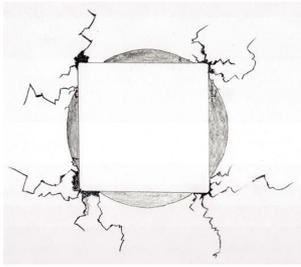
**Doesn't prescribe
SPC**




CERTAIN DEATH
BEYOND
THIS POINT!

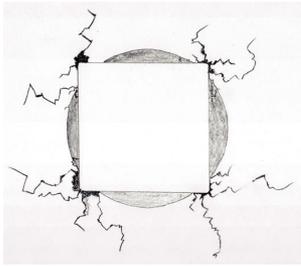
ANGER
VERY
THIN ICE.

THIN
ICE



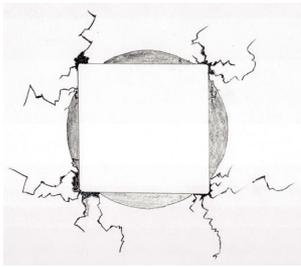
Problems

- ◆ The following slides present four specific problems which one faces when attempting to apply SPC to a human-intensive, knowledge-intensive process



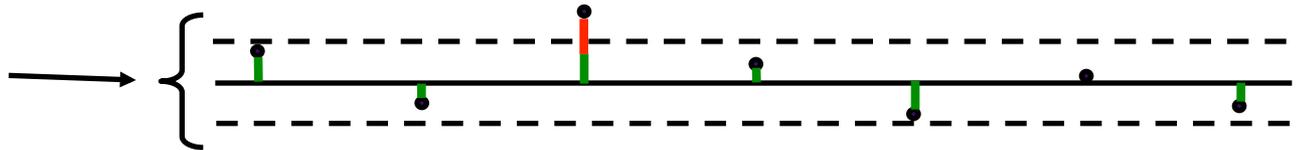
Problem #1 – Wide Control Limits

- ◆ When the normal variation is great (as in human-intensive, knowledge intensive processes) the control limits of the control charts become very wide, and almost all variation is considered normal



Problem #1 - Wide Control Limits

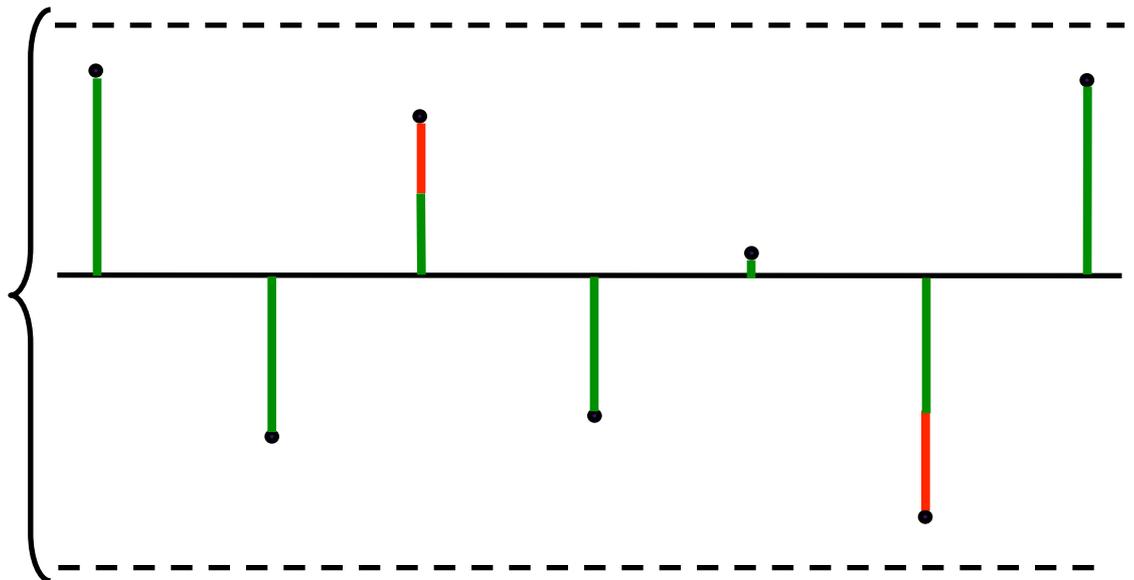
Narrow control limits

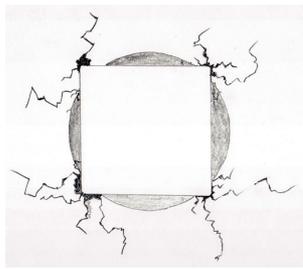


Wide control limits

Variation resulting from normal causes

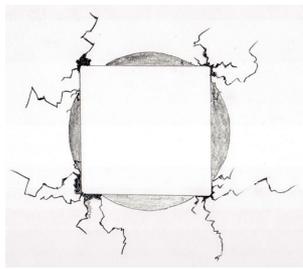
Variation resulting from an abnormal event





Problem #2 – Impossible to eliminate all assignable causes

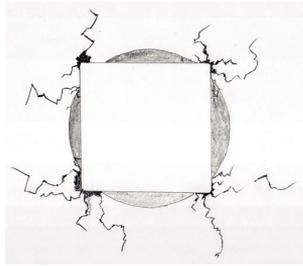
- ◆ First you have to detect them
- ◆ Then you have to identify them



Problem #2 – Impossible to eliminate all assignable causes

Some possible causes of variation in a human-intensive process:

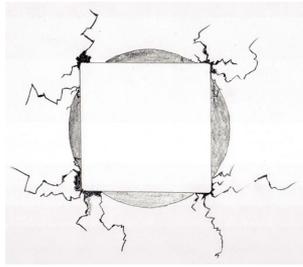
- ◆ Different people
- ◆ Same people, but one or more of the following applies to one or more of the people:
 - ◆ Has more job stress
 - ◆ Doesn't feel well
 - ◆ Has more family stress
 - ◆ Just quit smoking
 - ◆ Lack of sleep
 - ◆ Not enough caffeine
 - ◆ Going through a divorce
 - ◆ Mom died
 - ◆ Lack of nutrition
 - ◆ Under a schedule crunch
 - ◆ In a bad mood



Problem #2 – Impossible to eliminate all assignable causes

Some more possible causes of variation in a human-intensive process:

- ◆ Bitter due to lack of recognition
- ◆ Has a cold
- ◆ Distracted due to automobile issues
- ◆ Lack of exercise
- ◆ Distracted due to political issues
- ◆ Is cold
- ◆ Is hot
- ◆ Being bothered by mother-in-law
- ◆ Has health issues
- ◆ Is becoming unsatisfied with job
- ◆ Has a toothache
- ◆ Is tired
- ◆ Is not familiar with the piece of code being inspected
- ◆ Is hung-over
- ◆ Found out that he/she needs surgery
- ◆ Is recovering from surgery
- ◆ Is feeling depressed

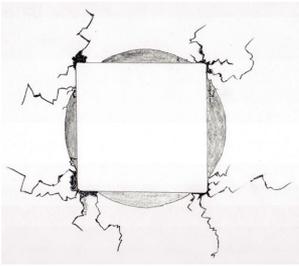


Problem #2 – Impossible to eliminate all assignable causes

- ◆ The list goes on and on

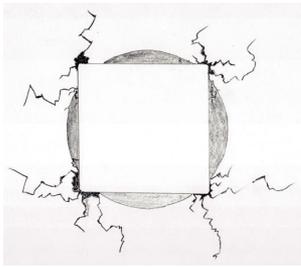
My point:

- ◆ In any human-intensive, knowledge-intensive process, assignable causes that are detected:
 - ◆ Are difficult if not impossible to **identify** and
 - ◆ Even if identified, are difficult if not impossible to **eliminate** from the process (much easier with machines)



Problem #3 – Each Individual Process is Different From Invocation to Invocation

- ◆ No statistician alive would ever mix data from different assembly lines in a single control chart
- ◆ Yet, that is exactly what happens when people attempt to apply SPC to software development process



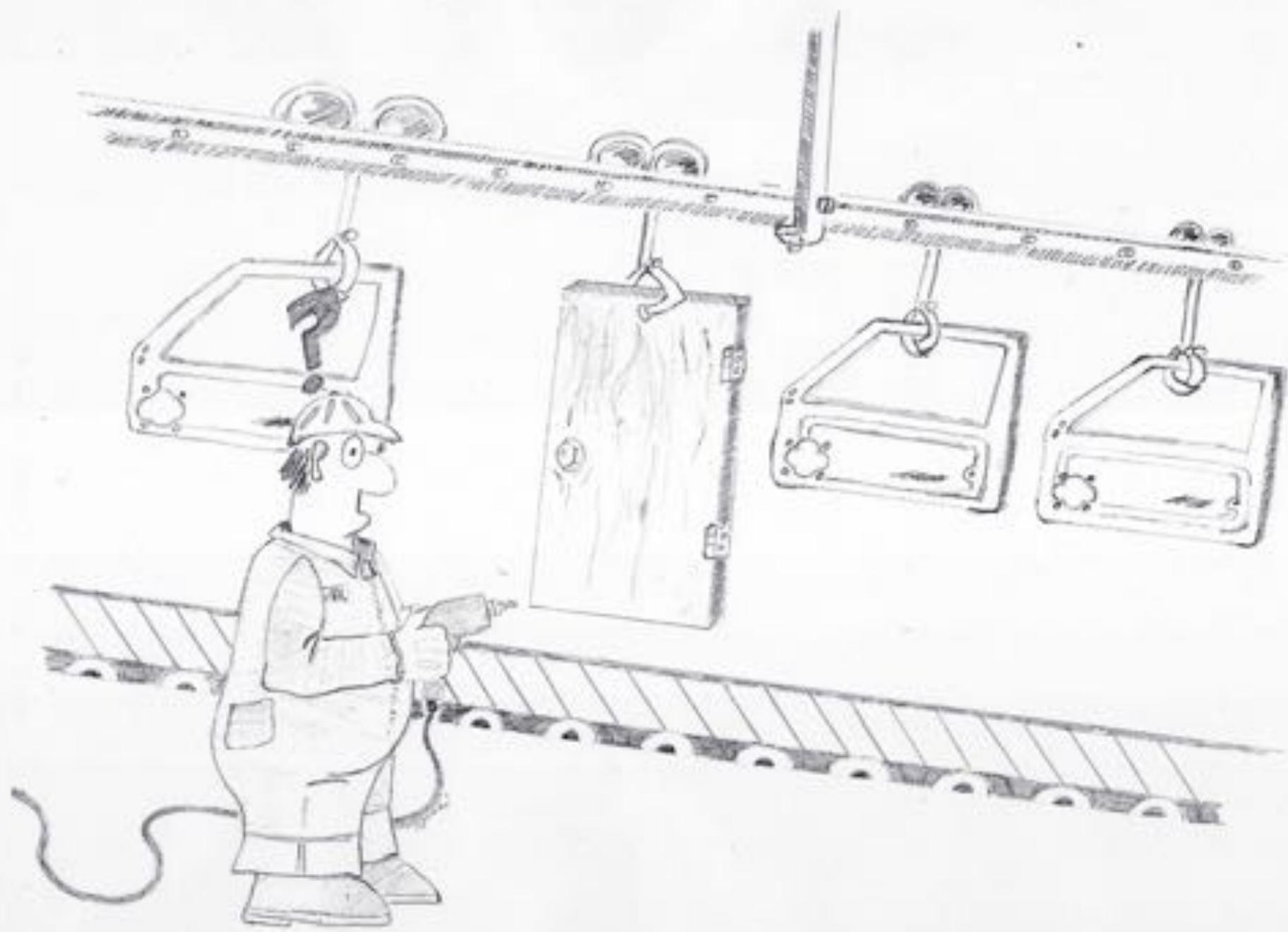
Problem #3

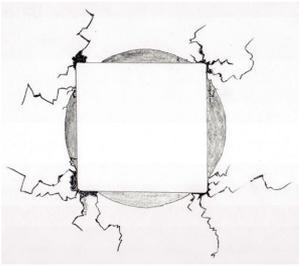
- Each Individual Process is

Different From Invocation to Invocation

-Are all processes alike?

	Processing elements between invocations virtually identical	Processing elements between invocations are different, but are in the same class	Processing between invocations in different class
Inputs between invocations virtually identical	Manufacturing process		
Inputs between invocations are different, but are in the same class		Software Inspection	
Inputs between invocations in different class			

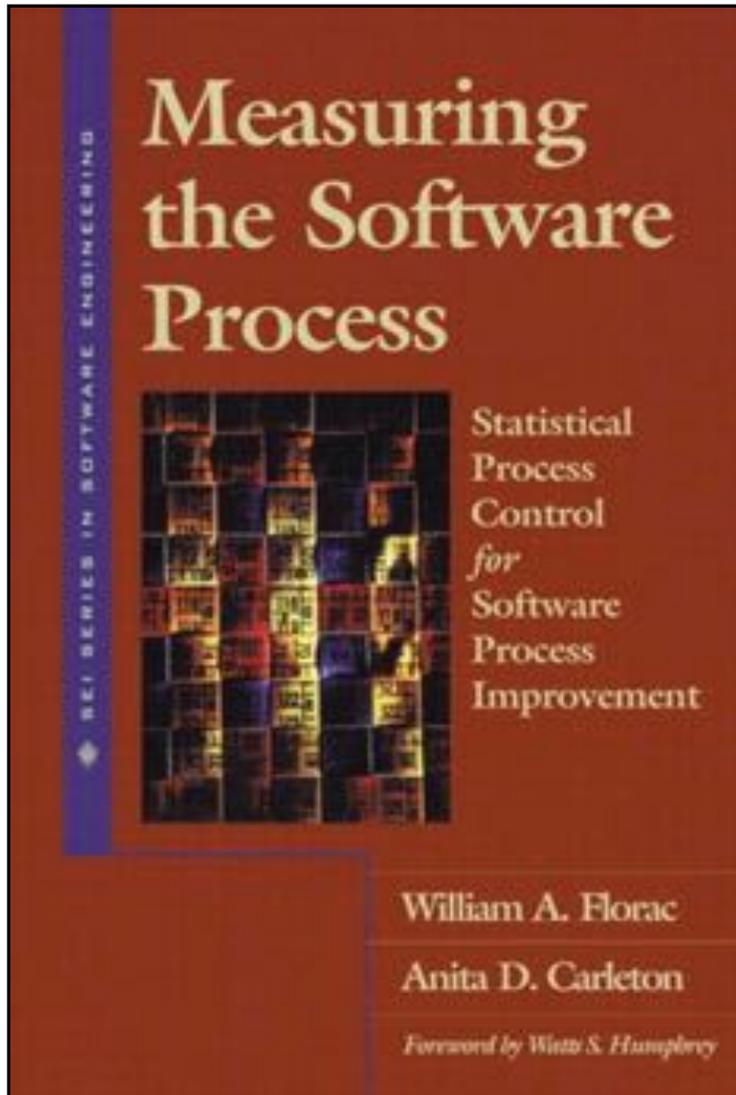




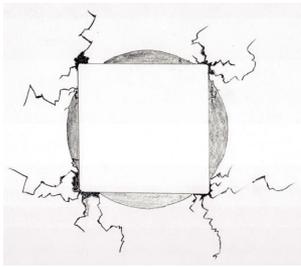
Problem #3 – Each Individual Process is Different From Invocation to Invocation

- ◆ With every invocation of a software development process:
 - ◆ The input(s) to the process are not virtually identical
 - ◆ The processing elements are not virtually identical
- ◆ In other words, there are multiple **common cause systems** present which are difficult if not impossible to isolate (resulting in **non-homogeneous data**)
- ◆ This is a fundamental distinction between manufacturing processes and human-intensive, knowledge-intensive processes

Problem #4 - Can't normalize the data



“We can conceive of situations, such as variations in the complexity of internal logic or in the ratios of executable to nonexecutable statements, where simply dividing by module size provides inadequate normalization to account for unequal areas of opportunity.”



Problem #4

Can't normalize the data

- ◆ The area of opportunity is not easily quantifiable, therefore normalizing the data isn't practical
- ◆ The code samples on the following two slides have vastly different areas of opportunity

```
#include <stdio.h>
#include <strings.h>
#include <stdlib.h>
```

```
int main(void)
{
    int number1, number2, number3, number4, number5, number6, ii;

    printf("\nPlease enter a number: "); scanf("%d", &number1);
    printf("\nPlease enter another number: "); scanf("%d", &number2);

    if ( number1 > number2 ) {
        printf("\nThe first number is greater");
    }
    if ( number2 > number1 ) {
        printf("\nThe second number is greater");
    }
    if ( number1 == number2 ) {
        printf("\nThe first and second numbers are equal");
    }

    number3 = number1 + number2; printf("\nAddition: %d + %d = %d", number1, number2, number3);
    number4 = number1 - number2; printf("\nSubtraction: %d - %d = %d", number1, number2, number4);
    number5 = number1 * number2; printf("\nMultiplication: %d x %d = %d", number1, number2, number5);
    number6 = number1 / number2; printf("\nDivision: %d / %d = %d (no remainder calculated)", number1, number2, number6);

    printf("\n\n Have a nice day!");
    return 0;
}
```

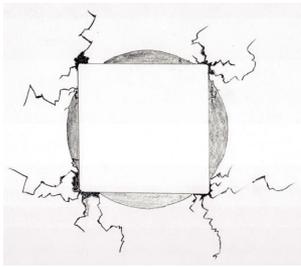
McCabe Cyclomatic Complexity = 4
Number of Logical SLOC = 31

```

#include <stdio.h>
#include <string.h>
void main( void )
{
    #define VAL 63
    struct d {
        short a,b,c;
        float aa;} e;
    register int xx = -12;
    volatile char cf = ~xx;
    short fc = cf<<1;
    memset( &e,0, sizeof e);
    xx = scanf( "%d %c", &fc, &cf);
    if(xx=cf=='f'?1:0) {
        e.a = 5;
        e.b = (e.a<<1)-1;
        e.c = (0x10)<<(2%e.a>>1);
        e.aa = (((float)(e.a))*(float)(e.b<<1))/(e.b*(VAL^45))*(float)(fc-( e.c == 1+(VAL>>1) ? 32:-44));
        printf( "%c = %f\n", 'A'+2, e.aa );}
    else {
        short a[VAL&~060] = { (VAL>>3)-2 };
        short * ptr = &a[ ((sizeof a)>>1) & 0xff5 ], **pptr = &ptr, *pttr = a;
        float * eaptr = &e.aa;
        *(++pttr) = e.c + 2*a[0] - e.a - (VAL>>a[0]);
            *(ptr -= 3) = ((*pttr + a[0])<<1) + sizeof (int);
        *eaptr = (float)(**pptr) + ((float)(*pttr*fc))/(float)a[0];
        printf("\nF = %f\n", e.aa );}
}

```

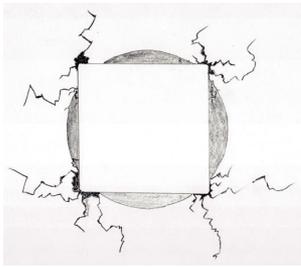
McCabe Cyclomatic Complexity = 4
 Number of Logical SLOC = 31



Problem #4

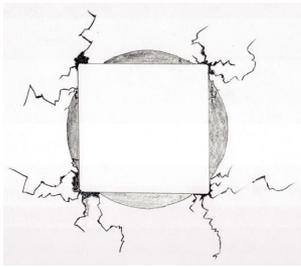
Can't normalize the data

- ◆ What is the area of opportunity of the previous two code samples?
 - ◆ I don't know
 - ◆ I have no way to accurately quantify it
 - ◆ I can subjectively state that the latter code sample has a far greater area of opportunity than the prior due to the complexity of the code



Can we get around these problems?

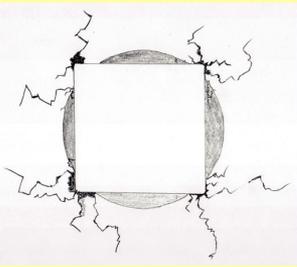
Problem	Typical “Solution(s)”
Problem #1 – Wide control limits	Assert that SPC is still applicable, the control limits are just wide
Problem #2 – Impossible to eliminate all assignable causes	Pretend that assignable causes are just like those present in manufacturing processes (can be easily detected, identified, and removed)
Problem #3 – Each Individual Process is Different From invocation to invocation	Assert that all processes are equal and continue to advocate SPC as a silver bullet. (Software Engineering = Hardware Manufacturing)
Problem #4 - Can't normalize the data	Divide by logical SLOC, separate data-lists, tables, and arrays from other code. Then claim that the unequal areas of opportunity have been accounted for.



Can we get around these problems?

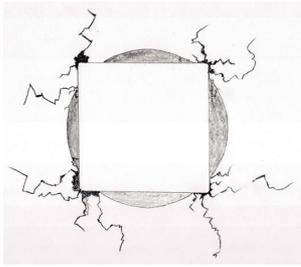
- ◆ Maybe the answer isn't to try so hard to get around the problems.
- ◆ Maybe SPC just isn't the right tool.
- ◆ Maybe we are trying too hard to fit a square peg into a round hole.

So was the SEI wrong about SPC for SW Dev processes?



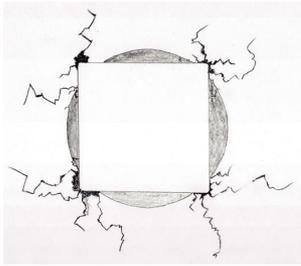
- ◆ Well, if you do apply SPC to software development processes, you might occasionally get lucky and **detect** an assignable cause of variation despite the wide control limits of your control charts, unequal area of opportunities, and ever-changing processes
- ◆ Of the assignable causes of variation that you do manage to detect, you might occasionally get lucky and actually **identify** one of the causes of that variation
- ◆ Of the very few assignable causes of variation that you manage to identify, one of them might occasionally be of a nature in which it can actually be **removed** with some persistence
- ◆ Even so, your overall system will hardly be more **predictable**

Is this the best use of your limited resources?



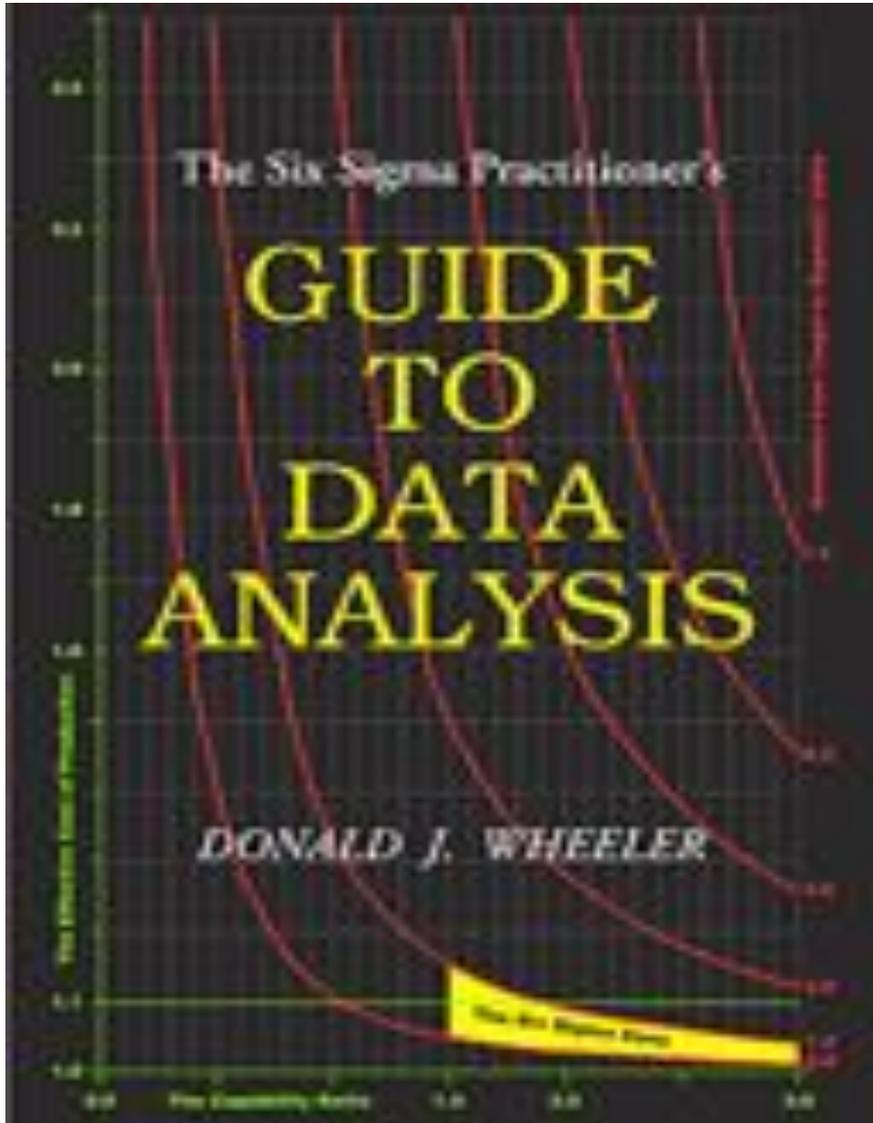
So was the SEI wrong about SPC?

- ◆ Technically, one can apply SPC to any process
- ◆ The Question is how useful doing so will be
- ◆ What the SEI got wrong is the amount of emphasis that they placed on using SPC with engineering processes

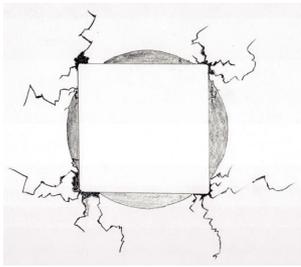


The other thing the SEI got wrong about SPC:

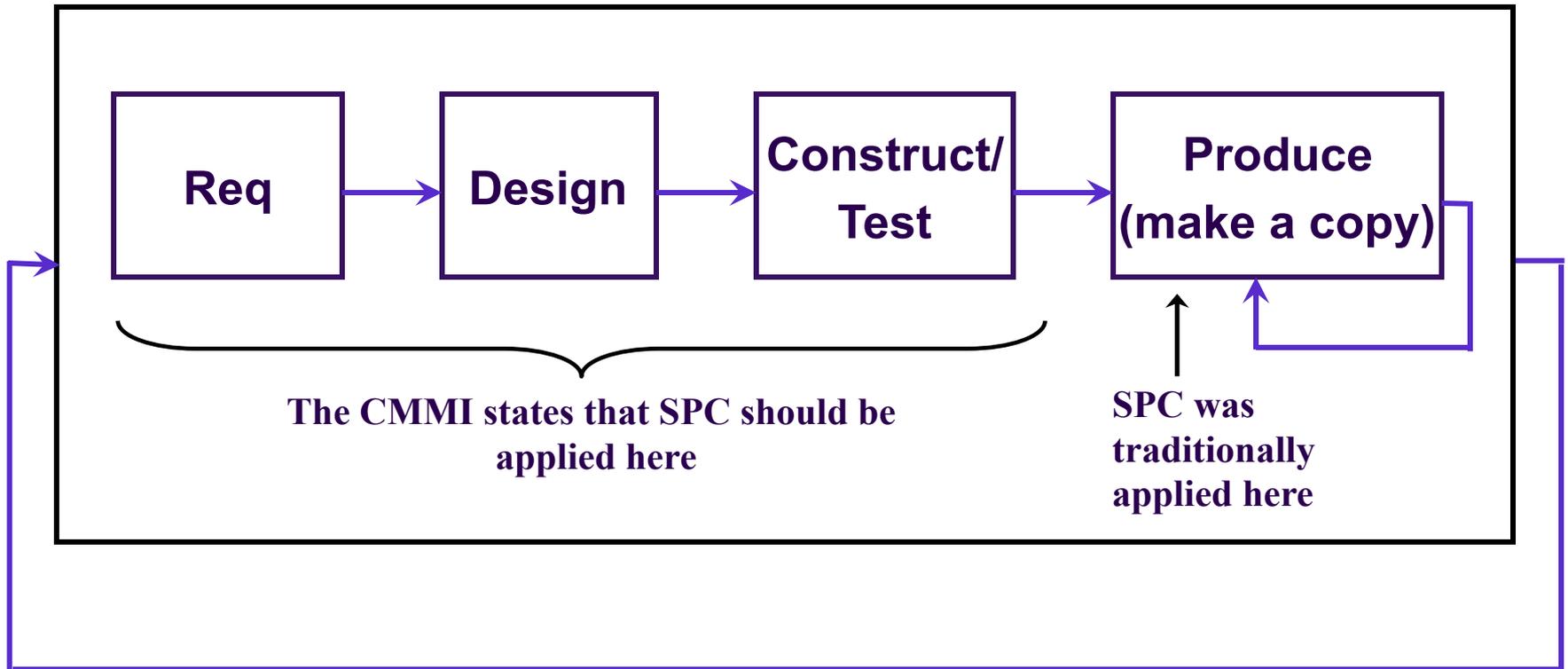
- ◆ Maturity Level 5: Optimizing
 - ◆ “Processes are continually improved based on a quantitative understanding of the common causes of variation inherent in processes.”

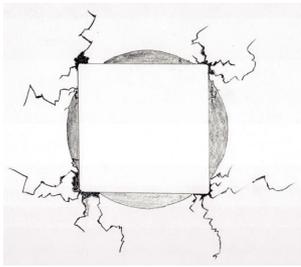


“Since reengineering a process is never cheap, it should be undertaken only when it is needed.”



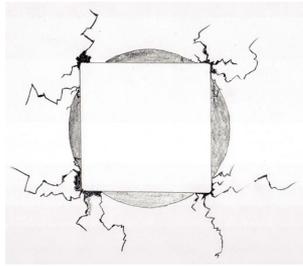
How did SPC get into the CMMI in the first place?





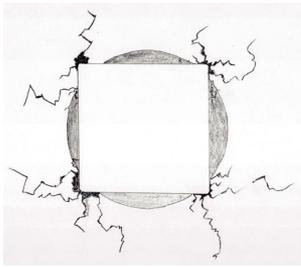
*How did SPC stay
in the CMMI for so long?*





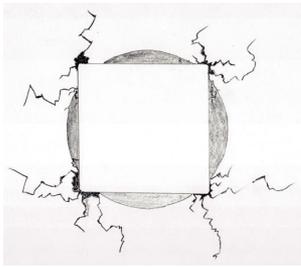
So, what is an alternative to SPC?

- ◆ Have experienced and technical SQE on your staff.
- ◆ By working directly with the people while the development is progressing they can:
 - ◆ Recognize when abnormal events are happening (even without control charts)
 - ◆ Frequently prevent problems before they occur
 - ◆ My experience is that other quantitative techniques are more useful (e.g. inspection coverage report)
 - ◆ Lead process improvement efforts (even without control charts)
- ◆ For predictability of the overall system, use a parametric modeling tool (e.g. SLIM by QSM)



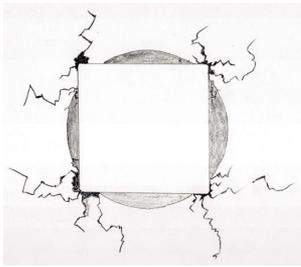
What the SEI needs to do

- ◆ De-emphasize SPC
 - ◆ Recommend taking the same approach as ISO 9001:2000:
“... shall include determination of applicable methods, including statistical techniques, and the extent of their use.”
- ◆ Consider collapsing at least level 5, and possibly levels 4 and 5, as the distinctions are largely based on SPC



Director of the SEI
- Nice guy. Give him a call

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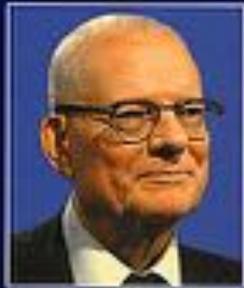


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One last Deming quote:

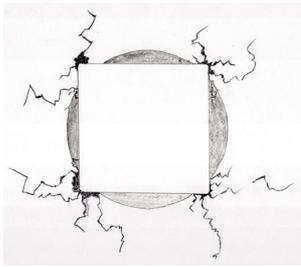
W. EDWARDS
DEMING



OUT OF
THE CRISIS

**“It is not necessary to change.
Survival is not mandatory.”**

- W. Edwards Deming



Acronym List

- ◆ PA – Process Area
- ◆ PSM – Practical Software and Systems Measurement
- ◆ QPM – Quantitative Project Management
- ◆ QSM – Quantitative Software Management
- ◆ SEI – Software Engineering Institute
- ◆ SG – Specific Goal
- ◆ SLIM – Software Lifecycle Management
- ◆ SLOC – Software Lines Of Code
- ◆ SP – Specific Practice
- ◆ SPC – Statistical Process Control
- ◆ SQE – Software Quality Engineer
- ◆ SW-CMM – Software Capability Maturity Model